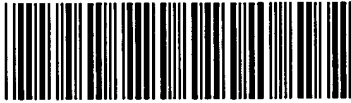


Search Notes

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10/754,530

Examiner

Hai C. Pham

Applicant(s)/Patent under
Reexamination

TSURUYA, TAKAAKI

Art Unit

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SEARCHED

Class	Subclass	Date	Examiner
347	232-235, 248-250	2/20/2006	HP
250	234	2/20/2006	HP
358	1.9	2/20/2006	HP

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST Text Search	2/20/2006	HP